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# Simulation and experimentation of an RFID system in the UHF band for the reliability of passive tags

Sanae Taoufik<sup>(1,2)</sup>, Ahmed El Oualkadi<sup>(1)</sup>, Farid Temcamani<sup>(3)</sup>, Bruno Delacressonniere<sup>(3)</sup>, Pascal Dherbécourt<sup>(2)</sup>

(1) Laboratory of Information Technology and Communication  
National School of Applied Sciences of Tangier, Abdelmalek Essaadi university, Morocco

(2) Materials Physics Group, UMR CNRS 6634 university of Rouen  
Avenue de l'université B.P 12 76801 Saint Etienne du Rouvray, France

Email: sanae.taou@gmail.com

(3) ECS-Lab EA3649 National School of Electronics and its applications  
6 Avenue du Ponceau 95014 Cergy Pontoise, France

**Abstract.** This paper presents the simulation of a UHF RFID (Radio Frequency Identification) system for passive tags, using Advanced Design System software from Agilent Company. Temporal measurements based on a commercial RFID reader are achieved which permit to analyze and to validate the principles of communication between the reader and the tag. Also a test bench is developed to evaluate the effects of high temperature on the reliability of passive UHF RFID tags. The obtained test results show that the thermal storage has a marked effect on the performances of the RFID tags.

**Keywords:** RFID, Passive tag, UHF band, simulation ADS, Reliability.

## 1. Introduction

Radio Frequency Identification (RFID) is a generic term used to describe a system which transmits an object or a person identity by using a radiofrequency link. Nowadays, the RFID technologies are used in many domains such as transport, medical treatment, smart cards...

Generally, RFID systems consist of two basic elements, a reader and a tag. The reader is composed of a high-frequency module, a control unit and an antenna [2]. The tag attached to an object, consists an antenna and a silicon chip, containing an identification code. According to the working frequency, RFID systems are classified in four frequency bands: low frequencies (LF) around 125 kHz, high frequencies (HF) at 13.56 MHz, ultra-high frequencies (UHF) at 860-960 MHz, and the microwaves at 2.4 GHz [3]. For the LF and HF systems, the communication distance is shorter than one meter. For UHF RFID systems, it reaches around five meters. The RFID systems are also classified according to the tag technology. Active RFID tags have a transmitter and their own power source (typically a battery). The power source is used

to run the microchip's circuitry and to broadcast a signal to a reader. Passive tags have no battery. Instead, they draw power from the reader, which sends out electromagnetic waves that induce a current in the tag's antenna [4]. This paper shows the design of a passive UHF RFID system. The system respects the EPC class1 Generation2 which is an air interface protocol first published by EPC global in 2004, it defines the physical and logical requirements for an RFID system of interrogators and passive tags, operating in the 860 MHz - 960 MHz UHF range. Over the past decade, EPC class1 Gen2 has been considered as the standard for UHF implementations across multiple sectors, and is at the heart of more and more RFID implementations [5].

## 2. Description of the RFID system architecture

The reader consists of a transceiver, with an antenna that communicates with a passive tag. The tag returns its identification code by retro-modulation. The RFID system, shown in figure 1, is simulated using the co-simulation between the numeric front end and the radio front end.

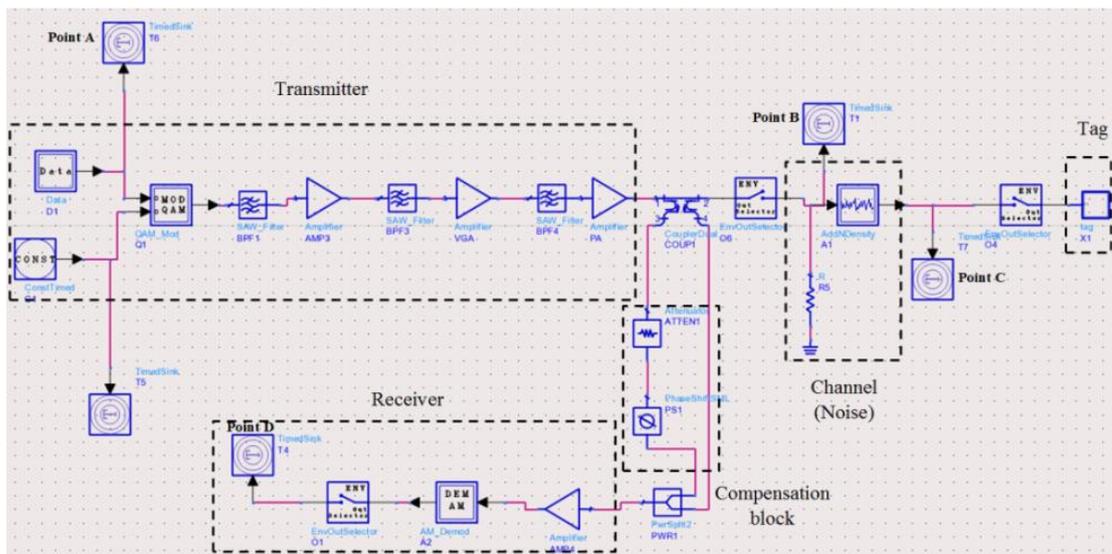


Fig. 1. Block diagram of the RFID communication system.

The transmitter part in the figure 1, is mainly made up of a digital data source and an ASK (Amplitude Shift Keying) modulator with internal oscillator. Filtering and amplification stages are also included, with a bandwidth in the (860-960) MHz range. Filters are used to reject the out-of-band spectrum.

The receiver part is also presented in figure 1. The received signal is first amplified by a low-noise amplifier (LNA), and then filtered and demodulated by an ASK demodulator. The emitted and received signals are separated by a directional coupler.

A compensation block is implemented to attenuate and phase shift the signal in order to reduce the isolations defects at reception [6].

The communication channel defect is modelled by an additive Gaussian filter to introduce sources of noise representing the environment.

Considering EPC Class 1 protocol, tags respond to the reader by retro-modulation sending the encode form signal shown in Figure 2. Two transitions are observed for a binary zero and four transitions are observed for a binary one during one elementary cell. The data rate of the returned signal is 140.35 Kbps (in North America) and 30 Kbps (in Europe) [7].

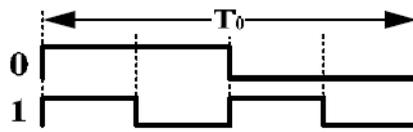


Fig. 2. EPC Class1 protocol signal encoding.

### 3. Simulation results

In this section, significant simulation results for each part of the system are presented. Figure 3 shows the simulation of PRBS (Pseudo Random Binary Sequence) data generated by the data-source from the reader transmitter (point A on Figure 1). The data rate is chosen equal to 100 Kbit/s corresponding to a bit time equal to 10  $\mu$ s. Figure 4 shows the modulated signal (point B on Figure 1) using DSB-ASK (Double-side band amplitude shift keying) modulation sent by the reader transmitter.

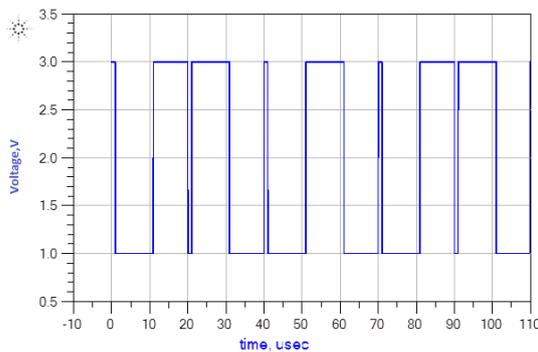


Fig. 3. Digital data to be transmitted.

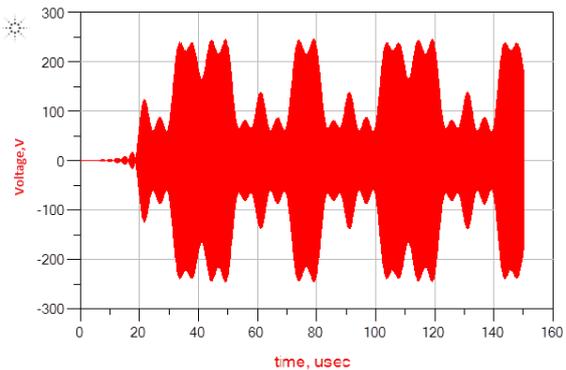


Fig. 4. Carrier modulated by the data.

Considering the operational working, the modulated signal is transmitted to the tag, which returns its coded identification. In order to simulate this process, the tag is considered as a data autonomous source. Figure 5 shows the encoded data sent by the tag (point C on Figure 1). Figure 6 (point D on Figure 1) shows the demodulated

signal using the encoding according to Class 1 protocol. The data represent the binary sequence “111111100100001...”. The modulated signal is transmitted through the compensation block. The data are thus available at the output of the receiver circuit. Figure 6 shows that the received data correspond to the data sent by the tag, as we expected.

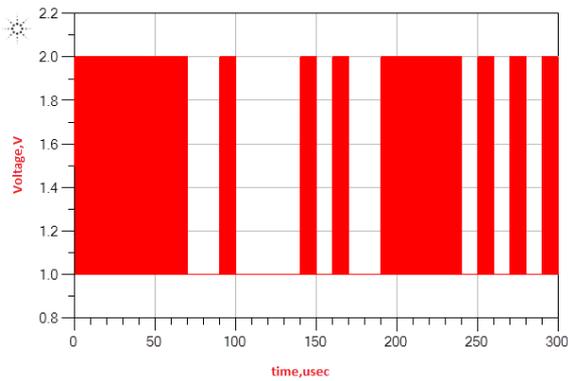


Fig. 5. Signal sent by the tag.

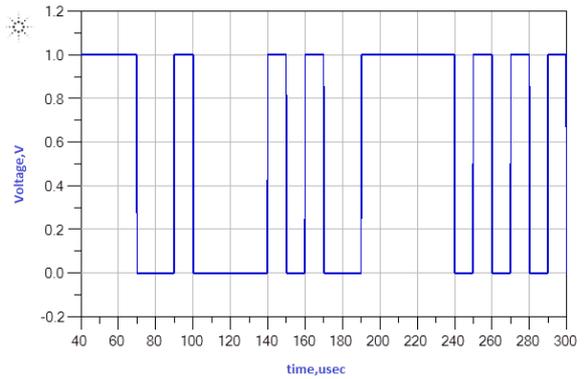


Fig. 6. Signal received by the reader.

#### 4. Description of measurement bench

In order to study the robustness and the reliability of passive tags submitted to severe environmental constraints, we have developed the measurement bench shown in Figure 7. The commercial reader SPEEDWAY [8] is controlled by the PC (hot), it is connected to an antenna placed on a turntable 360°. The tag to be tested is placed on a stand disposed on a slide rail for a distance of up to 2 meters. Placed in an open environment of obstacles, this bench allows readings of the power reflected by the tag depending on the distance.

The bench can operate with four possible frequencies in the UHF band, corresponding to the European standard: 866.30 MHz - 866.90 MHz - 867.5 MHz or 865.7 MHz, the emitted power of the reader can reach 30 dBm, the gain of the antenna is 6 dBi.

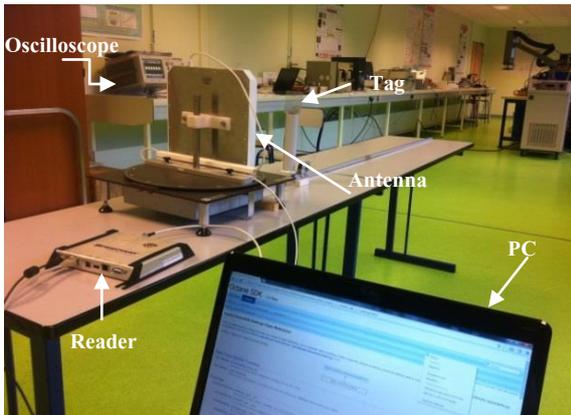


Fig. 7.a. View of the test bench.



Fig. 7.b. Tag mounted on the sliding support.

The passive tag chosen under test is shown in Figure.7.c. Its size is 40 mm x 54 mm and it can be easily attached to the object to be stored. It meets the requirements of EPC Class 1 Generation 2 (Gen 2) ISO 18 000-6C, and has an antenna attached to an integrated memory chip containing its unique identifier whose memory is 96 bits, or 12 bytes.

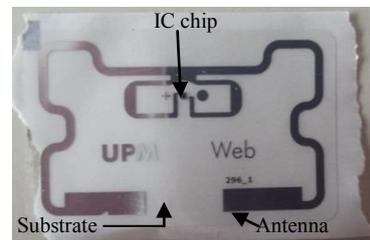


Fig. 7.c. View of the UPM Web tag.

## 5. Time measurements for the communication Reader / tag

Figure 8 shows chronograms recorded using the oscilloscope “Agilent Infinium” with a 6 GHz bandwidth, covering the UHF range. Figure 8 shows the signal sent by the reader with the presence of a tag placed in the reading field. As expected, a DSB-ASK modulation signal measured.

As shown in chronograms, part A of the signal represents the continuous wave (CW) signal suitable to feed the tag. Part B represents the instruction sent to the tag.

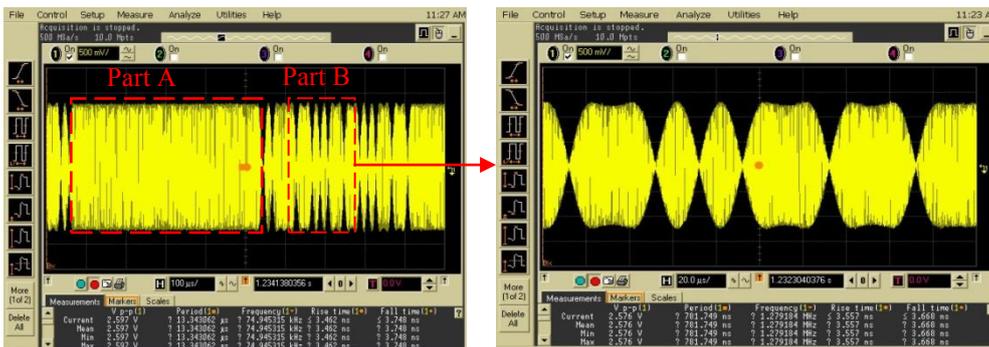
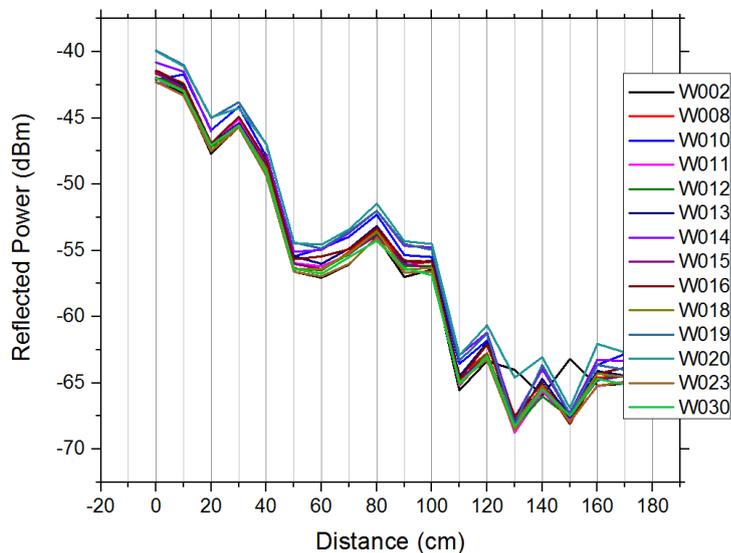


Fig. 8. Time measurements for communication between reader / tag.

## 6. Experimental results for tag reliability study

### 6.1 Experimental process conditions

In this section some tests on tags are performed and presented, using the bench describe in paragraph 4. The operating frequency band depends mainly on the RFID reader used. The working frequency is equal to 865.7 MHz. The reader generates a radio frequency signal transmitted by a coaxial cable to the antenna. The tag under test is positioned on a rail. The distance can be adjusted in a 200 cm range. The tag receives the signal and returns its identification code, the reflected power measured and displayed on the screen of a PC connected to the RFID reader.



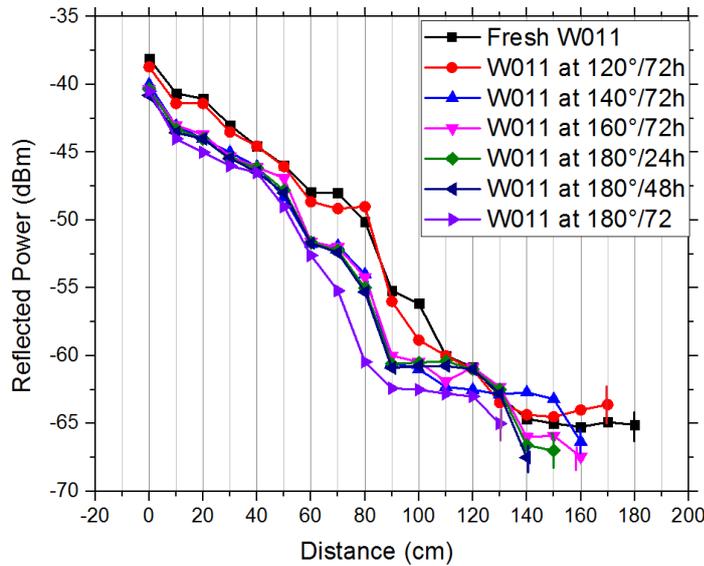
**Fig. 9.** Reflected power by the tags vs distance.

To get representative values, fourteen fresh tags for first series were tested. The results of these tests are shown in Figure 9. The power emitted by the reader is fixed to 27 dBm. The measurements reveal no significant variations of the reflected power (standard deviation 2.07 %) for the different tags, showing a similar behavior. These results show that the bench is fully operational to meet the needs of this study.

### 6.2 Aging reliability tests

Passive UHF RFID tags are used for object identification in various environmental conditions which may affect their reliability [9,10]. In order to evaluate the degradation of the performances, the effect of different temperatures is studied [11].

According to the manufacturer [12] the tags under study can operate efficiently in the temperature range between  $-40\text{ }^{\circ}\text{C}$  and  $85\text{ }^{\circ}\text{C}$ . To study the impact of accelerated life tests, storages under high temperatures are performed on three tags. The starting temperature was set at  $100\text{ }^{\circ}\text{C}$  corresponding to an overtaking close to 20% of the maximum value recommended by the manufacturer. The selected step is  $20\text{ }^{\circ}\text{C}$ ; storage time is 72 hours by step. The results for storage temperatures are shown in Figure 10.



**Fig. 10.** Reflected power by W011 vs distance

The performance parameters of the tag are significantly changed during the tests, the reflected power decreases after each test which strongly influence the range of the tag. Harder accelerated life tests are underway and the stress levels are in progress to accelerate the failures mechanisms.

## 7. Conclusion and perspectives

The purpose of this work is to study the robustness and reliability of RFID systems in the UHF band under stern environmental conditions. A failure analysis will be implemented in order to determine accurately the type of defect. Moreover, the metallization of the antenna should be examined with an optical microscope to identify any cracks which will affect the performance of the tags. In addition, with a series of thirty devices, a statistical analysis using the predicted reliability calculation tools should be implemented to determine the mechanisms failures acceleration. Based on the simulations developed under ADS software, our objective is developing a reader based on discrete components. The system will be able to communicate with

the tags that will be tested by varying the transmit power and the frequency throughout the whole UHF band.

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